

Low voltage electrical injury induces psychosis

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Psychosomatics

2012; 53(2):197-198

ARTICLE IDENTIFIERS

DOI: 10.1016/j.psych.2011.11.008

PMID: 22424170

PMCID: not available

JOURNAL IDENTIFIERS

LCCN: 65029473

pISSN: 0033-3182

eISSN: 1545-7206

OCLC ID: 01763070

CONS ID: not available

US National Library of Medicine ID: 0376506

This article was identified from a query of the SafetyLit database.